	Application No.	Applicant(s)
Notice of Allowability	09/765,995	ALUMOT ET AL.
	Examiner	Art Unit
	Mehrdad Dastouri	2623
- The MAILING DATE of this communication appears on the cover sheet with the correspondence address— All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.  1. ☑ This communication is responsive to Appeal Brief filed on September 22, 2004.  2. ☑ The allowed claim(s) is/are 96-105 (Renumbered 1-10).  3. ☑ The drawings filed on June 25, 2001 are accepted by the Examiner.  4. ☑ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).  a) ☑ All b) ☐ Some* c) ☐ None of the:  1. ☐ Certified copies of the priority documents have been received.  2. ☑ Certified copies of the priority documents have been received in Application No. 07/790,871.  3. ☐ Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).  * Certified copies not received:  Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.  THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		
<ul> <li>5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.</li> <li>6. CORRECTED DRAWINGS ( as "replacement sheets") must be submitted. <ul> <li>(a) including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached</li> <li>1) hereto or 2) to Paper No./Mail Date</li> <li>(b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date</li> <li>Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).</li> </ul> </li> <li>7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.</li> </ul>		
Attachment(s)  1. Notice of References Cited (PTO-892)  2. Notice of Draftperson's Patent Drawing Review (PTO-948)  3. Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date  4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Summary Paper No./Mail Dat 98), 7. ☐ Examiner's Amendr	te

Application/Control Number: 09/765,995

Art Unit: 2623

## **DETAILED ACTION**

1. Appellant' arguments (Appeal Brief Filed September 22, 2004, Pages 7-8 (Section V, Summary of the Claimed Subject Matter); Pages 12-13, Section VII, Prosecution History, Items 1), 2) and 3)) are persuasive. Rejection of Claims 96-105 has been withdrawn accordingly.

## Allowable Subject Matter

2. The following is an examiner's statement of reasons for allowance:

The Examiner agrees with Appellants' detailed explanation of "Summary of the Claimed Subject Matter" in Pages 7 and 8 of the Appeal Brief. As thoroughly described in this explanation:

The claimed subject matter of the instant invention is directed to an apparatus for inspection of patterned semiconductor wafers in two phases. In the first phase, the complete surface of the wafer substrate is inspected utilizing a comparator for calculating a difference between the inspection signals outputted from the first collection optics and a reference signal to identify locations on the substrate of having defects thereupon (suspected locations) based on a threshold outputted from threshold processor 70.

In the second phase, the suspected locations having a high probability of a defect are received by second collection optics and images indicating the presence or absence of a defect in each suspected location are outputted to a defect classifier for classifying said images outputted from second phase processing.

Application/Control Number: 09/765,995 Page 3

Art Unit: 2623

The features identified, in combination, are neither discussed nor suggested by the prior arts of record.

- 3. Claims 96-105 are allowed.
- 4. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## **Contact Information**

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Mehrdad Dastouri whose telephone number is (703) 305-2438. The examiner can normally be reached on Monday to Friday from 8:00 a.m. to 4:30 p.m..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amelia Au can be reached on (703) 308-6604. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should

Art Unit: 2623

you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

MEHRDAD DASTOURI PRIMARY EXAMINER Which dad Dastoni

Mehrdad Dastouri Primary Examiner Group Art Unit 2623 January 15, 2005